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# SN65ELT22

# 5-V Dual TTL-to-Differential PECL Translator

#### **FEATURES**

- 1.1-ns (max) Propagation Delay
- Operating Range: V<sub>CC</sub> = 4.2V to 5.7V with GND = 0 V
- < 50-ps (typ) Output-to-Output Skew</li>
- Built-In Temperature Compensation
- Drop-In Compatible to the MC10ELT22, MC100ELT22

### **APPLICATIONS**

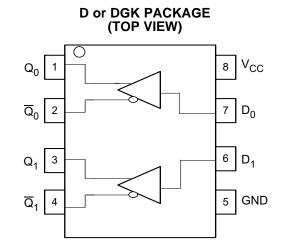
- Data and Clock Transmission Over Backplane
- Signaling Level Conversion for Clock or Data

### DESCRIPTION

The SN65ELT22 is a dual TTL-to-differential PECL translator. It operates on +5-V supply and ground only. The output is undetermined when the inputs are left floating. The low output skew makes the device an ideal solution for clock or data signal translation.

The SN65ELT22 is housed in an industry standard SOIC-8 package and is also available in an optional TSSOP-8 package.

### PIN ASSIGNMENT



#### Table 1. Pin Descriptions

PIN	FUNCTION					
D <sub>0</sub> , D <sub>1</sub>	TTL inputs					
$Q_0, \overline{Q}_0, Q_1, \overline{Q}_1$	PECL outputs					
V <sub>CC</sub>	Positive supply					
GND	Ground					

#### ORDERING INFORMATION<sup>(1)</sup>

PART NUMBER	PART MARKING	PACKAGE	LEAD FINISH
SN65ELT22D	SN65ELT22	SOIC	NiPdAu
SN65ELT22DGK	SN65ELT22	SOIC-TSSOP	NiPdAu

(1) Leaded device options are not initially available; contact a sales representative for further details



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### SN65ELT22

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

PARAMETER	CONDITIONS	VALUE	UNIT		
Absolute PECL mode supply voltage, $V_{CC}$	GND = 0 V	6	V		
Input voltage, V <sub>IN</sub>	GND = 0 V	GND + 0.025 < V <sub>IN</sub> < V <sub>CC</sub> - 0.025	V		
Output ourroat	Continuous	50	~		
Output current	Surge	100	mA		
Operating temperature range		-40 to 85	°C		
Storage temperature range	emperature range -65 to 150				

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### POWER DISSIPATION RATINGS

PACKAGE	CIRCUIT BOARD MODEL	POWER RATING T <sub>A</sub> < 25°C (mW)	THERMAL RESISTANCE, JUNCTION-TO-AMBIENT NO AIRFLOW	DERATING FACTOR T <sub>A</sub> > 25°C (mW/°C)	POWER RATING T <sub>A</sub> = 85°C (mW)
SOIC	Low-K	719	139	7	288
5010	High-K	840	119	8	336
SOIC-TSSOP	Low-K	469	213	5	188
3010-1330P	High-K	527	189	5	211

#### THERMAL CHARACTERISTICS

	PARAME	TER	MIN	TYP	MAX	UNIT		
0	lunction to board thermal registeres	SOIC		79		°C/W		
$\theta_{JB}$	Junction-to-board thermal resistance	SOIC-TSSOP		120		-0/00		
0	lunation to appa thermal registeres	SOIC		98		0CAN		
$\theta_{\text{JC}}$	Junction-to-case thermal resistance	SOIC-TSSOP		74		°C/W		

#### **KEY ATTRIBUTES**

CHARACTERISTICS		VALUE
Moisture sensitivity level		Level 1
Flammability rating (oxygen index: 28 to	UL 94 V-0 at 0.125 in	
	Human body model	4 kV
Electrostatic discharge	Charge device model	2 kV
	Machine model	200 V
Meets or exceeds JEDEC Spec EIA/JES	D78 latchup test	



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#### PECL DC CHARACTERISTICS

At  $V_{CC} = 5.0$  V, GND = 0.0 V (unless otherwise noted)<sup>(1)(2)</sup>

PARAMETER		TEST CONDITIONS	T <sub>A</sub> = -40°C			T <sub>A</sub> = 25°C			T <sub>A</sub> = 85°C			
		TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
I <sub>CC</sub>	Power supply current			17.3	20		18.2	20		19.4	22	mA
V <sub>OH</sub>	High-level output voltage	See <sup>(3)</sup>	3915	3954	4120	3915	3958	4120	3915	3961	4120	mV
V <sub>OL</sub>	Low-level output voltage	See <sup>(3)</sup>	3170	3236	3380	3170	3231	3380	3170	3229	3380	mV

(1) The device meets the specifications after thermal balance has been established when mounted in a socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are assured only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

(2) Input and output parameters vary 1:1 with V<sub>CC</sub>. V<sub>CC</sub> can vary +0.7 V /–0.8 V.

(3) Outputs are terminated through a 50- $\Omega$  resistor to V<sub>CC</sub> – 2.0 V.

### TTL DC CHARACTERISTICS

At  $V_{CC} = 4.2$  V to 5.7 V,  $T_A = -40^{\circ}$ C to 85°C (unless otherwise noted)<sup>(1)</sup>

	PARAMETER	TEST CONDITIONS	MIN	TYP MAX	UNIT
I <sub>IH</sub>	High-level input current	$V_{IN} = 2.7 \text{ V}, V_{IN} = (V_{CC} - 0.025) \text{ V}$		20	μA
I <sub>IHH</sub>	High-level input current	V <sub>IN</sub> = V <sub>CC</sub>		20	μA
$I_{IL}$	Low-level input current	$V_{IN} = 0.5 \text{ V}, V_{IN} = (\text{GND} + 0.025) \text{ V}$		-200	μA
V <sub>IK</sub>	Input clamp diode voltage	$I_{IN} = -18 \text{ mA}$		-1.2	V
VIH	High-level input voltage		2.0	Vcc- 0.025	V
$V_{\text{IL}}$	Low-level input voltage		GND + 0.025	0.8	V

(1) The device meets the specifications after thermal balance has been established when mounted in a socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are assured only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously

### **AC CHARACTERISTICS**

At  $V_{CC}$  = 4.2 V to 5.7 V, GND = 0.0 V (unless otherwise noted)<sup>(1)</sup>

	PARAMETER	TEST CONDITIONS	T,	<sub>4</sub> = -40°	°C	Τ,	م = 25°	С	T,	م = 85°	С	UNIT
	PARAWEIER	TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
f <sub>MAX</sub>	Max switching frequency <sup>(2)</sup> , see Figure 5			500			490			470		MHz
t <sub>PLH</sub>	Dronogotion dolou time		0.6	0.83	1.1	0.6	0.84	1.1	0.6	0.85	1.1	20
t <sub>PHL</sub>	<ul> <li>Propagation delay time</li> </ul>	1.5 V to 50%	0.5		0.9	0.5		0.9	0.5		0.9	ns
	Within device skew	See <sup>(3)</sup>		25	90		25	90		25	90	
t <sub>SKEW</sub>	Device-to-device skew	See (4)		25	100		25	100		25	100	ps
t <sub>JITTER</sub>	Random clock jitter (RMS)				0.5			0.5			0.5	ps
t <sub>r</sub> /t <sub>f</sub>	Output rise/fall times	Q (20%–80%)	0.7		1.1	0.7		1.1	0.7		1.1	ns

(1) The device meets the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are assured only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

(2) Maximum switching frequency measured at output amplitude of 300 mV<sub>pp</sub>.

(3) Measured between outputs under the identical transitions and conditions on any one device.

(4) Device-to-device skew for identical transitions at identical V<sub>CC</sub> levels.

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### Typical Termination for Output Driver

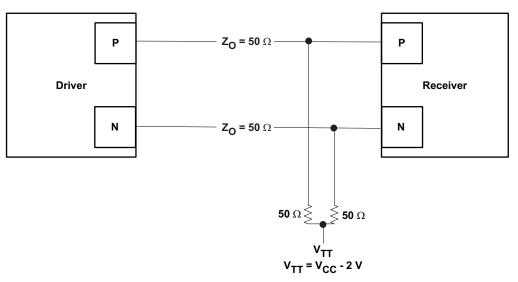


Figure 1. Typical Termination for Driver

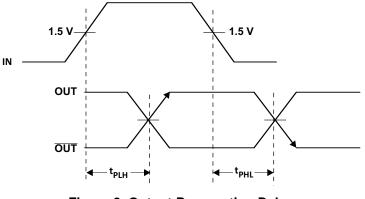


Figure 2. Output Propagation Delay

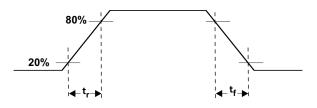


Figure 3. Output Rise and Fall Times

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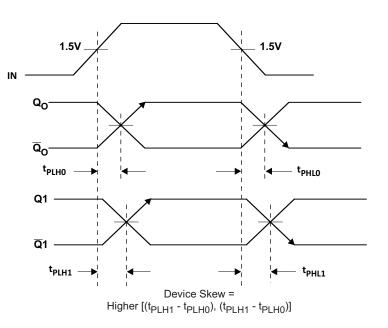


Figure 4. Device Skew

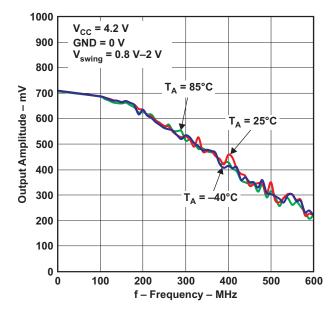


Figure 5. Output Amplitude vs. Frequency



#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
SN65ELT22D	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ELT22	Samples
SN65ELT22DGK	ACTIVE	VSSOP	DGK	8	80	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	SIPI	Samples
SN65ELT22DGKR	ACTIVE	VSSOP	DGK	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	SIPI	Samples
SN65ELT22DR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ELT22	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## PACKAGE MATERIALS INFORMATION

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#### TAPE AND REEL INFORMATION





### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65ELT22DGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
SN65ELT22DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

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## PACKAGE MATERIALS INFORMATION

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65ELT22DGKR	VSSOP	DGK	8	2500	853.0	449.0	35.0
SN65ELT22DR	SOIC	D	8	2500	853.0	449.0	35.0

DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.

- D Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.



# DGK (S-PDSO-G8)

### PLASTIC SMALL OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# D0008A



# **PACKAGE OUTLINE**

### SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.

- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



# D0008A

# **EXAMPLE BOARD LAYOUT**

### SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## D0008A

# **EXAMPLE STENCIL DESIGN**

### SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



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